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# Wavelet Entropy-Based Traction Inverter Open Switch Fault Diagnosis in High-Speed Railways

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**Abstract:** In this paper, a diagnosis plan is proposed to settle the detection and isolation problem of open switch faults in high-speed railway traction system traction inverters. Five entropy forms are discussed and compared with the traditional fault detection methods, namely, discrete wavelet transform and discrete wavelet packet transform. The traditional fault detection methods cannot efficiently detect the open switch faults in traction inverters because of the low resolution or the sudden change of the current. The performances of Wavelet Packet Energy Shannon Entropy (WPESE), Wavelet Packet Energy Tsallis Entropy (WPETE) with different non-extensive parameters, Wavelet Packet Energy Shannon Entropy with a specific sub-band (WPESE<sub>3,6</sub>), Empirical Mode Decomposition Shannon Entropy (EMDESE), and Empirical Mode Decomposition Tsallis Entropy (EMDETE) with non-extensive parameters in detecting the open switch fault are evaluated by the evaluation parameter. Comparison experiments are carried out to select the best entropy form for the traction inverter open switch fault detection. In addition, the DC component is adopted to isolate the failure Isolated Gate Bipolar Transistor (IGBT). The simulation experiments show that the proposed plan can diagnose single and simultaneous open switch faults correctly and timely.

**Keywords:** open switch fault; wavelet transform; wavelet packet transform; Shannon entropy; Tsallis entropy; traction inverter; high-speed railway

## 1. Introduction

Vector controlled drive systems are widely adopted in the high-speed railways of China. In this kind of drive system, the traction inverters are essential to meet the control demand. However, the traction inverters are prone to suffer failures because of their complex working environment and exposure to high stress [1]. These failures threaten the train's operational safety. Fortunately, a fault tolerant strategy, which requires the timely and correct diagnosis of traction inverter failures, is a feasible way to avoid this risk [2,3].

An earlier survey has pointed out that semiconductor power devices (SPDs) ranked among the most fragile components in power electronic converters [4]. SPD failures include open switch faults and short switch faults. The short switch faults will cause an intense increase of the load current. As a result, the time between fault initiation and failure is very short, which makes it difficult to execute diagnosis algorithms. Hence, the existing short switch fault diagnosis methods are almost always based on hardware [5]. As for the open switch faults, the system can still run for a while, which may cause additional failures and damage the system. Therefore, it is important to diagnose open switch faults in time.

Recently, numerous methods for the fault diagnosis of SPDs failures have been proposed [6–19]. These methods can mainly be divided into model-based approaches [6–9] and signal-based approaches [10–19]. Generally, the model-based approaches perform the diagnosis by generating the residuals which will not exceed the threshold unless the failures occur. In [6], the residuals were defined as the difference between the theoretical voltage and actual voltage across each SPD. In addition, the hardware was adopted to decrease the sensors. However, the cost would increase compared with [7–9]. In [7], robust residuals were constructed by combining two nonlinear Luenberger observers with a directional evaluation. The residuals could identify the fault bridge and the directional value can locate the failure SPD. In [8], a residual, which had robustness against false alarms, was constructed by employing a voltage observer, coupled with the DC voltage. The diagnosing rule was similar to [7]. In [9], a model-based approach based on the cross correlation between the estimated phase currents by a sliding mode observer and the real currents was proposed.

Signal-based approaches are mainly based on the output current or voltage of the inverter. The average values and average absolute values of stator currents were adopted as principal quantities to formulate the diagnostic variables [10,11]. The Concordia current pattern could also detect the open switch fault and identify the failure SPD [12]. Extra component analysis, averaging, and waveform analysis were adopted in [13] to identify the failure SPD. In [14], a discrete wavelet transform was utilized to detect SPD failures. Then the value and the polarity of DC offset of each phase current were fed to a fuzzy logic system to isolate the failed SPD. Multi-resolution based on wavelet transform was performed in [15,16], and the features of open switch faults were discussed. However, it was argued in [17] that a sudden change of current amplitude by transient states was the obstacle in performing fault diagnosis by wavelet transform, and the normalized form of each phase was adopted. However, this form would change the waveform of the fault-free phase currents, which made it difficult to diagnose the simultaneous faults. In [18,19], the numerical values of wavelet coefficients were adopted instead of the waveform, and improved support vector machines were proposed to classify the faults.

Based on the above discussion, it can be found that the wavelet transform may not be a good method to deal with traction inverter open switch faults. On one hand, the sudden change of current amplitude by transient states will cause false alarms, and the current contains higher extra components that may cover the fault signal. On the other hand, if any measure is adopted to deal with the phenomenon mentioned above, the fault-free phase currents might be influenced at the same time, which makes it hard to diagnose the simultaneous faults.

Recently, entropy has shown outstanding performance in the fault detection domain [20–23]. In [20], multi-wavelet singular entropies were proposed to detect and classify faults in power transmission lines. In [21,22], wavelet singular entropy and relative entropy of wavelet energy were utilized in power system protection applications. In [23], multi-level wavelet Shannon entropy was proposed to isolate single-sensor faults.

Considering the ability of entropy in fault detection, a plan for traction inverter open switch fault diagnosis based on wavelet packet entropy is proposed in this paper. This plan mainly consists of two parts, namely, the fault detection part and the fault location part. For the fault detection part, five entropy forms, *i.e.*, Wavelet Packet Energy Shannon Entropy (WPESE), Wavelet Packet Energy Tsallis Entropy (WPETE) with different non-extensive parameters, Empirical Mode Decomposition Shannon Entropy (EMDESE), Wavelet Packet Energy Shannon Entropy with a specific sub-band (WPESE<sub>3,6</sub>) and Empirical Mode Decomposition Tsallis Entropy (EMDETE) with different parameters are tried to overcome the defects of the traditional fault detection methods. For the fault isolation part, the DC component of each faulty leg is calculated to identify the Upper Switch Fault (USF) and Lower Switch Fault (LSF). Finally, simulation experiments are performed to validate the effectiveness of the proposed methodology.

## 2. Disadvantages of Wavelet and Wavelet Packet in Traction Inverter Diagnosis

The schematic diagram of traction system is shown in Figure 1. The traction inverter mainly consists of six SPDs, namely *S*1, *S*2, *S*3, *S*4, *S*5, *S*6. Insulated Gate Bipolar Transistors (IGBTs) with antiparallel diodes are commonly adopted SPDs [7]. In the traction system, the vector control is utilized to decouple the excitation current and torque current. Hence, it can be easier to control the motor's torque. The A-phase current and motor's torque under normal condition and *S*1 open switch fault condition are shown in Figure 2, respectively. It can be found that the open switch fault will cause a sudden change of the torque, which may damage the traction motor and may threaten the passengers' safety.

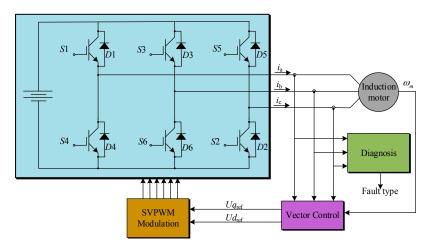
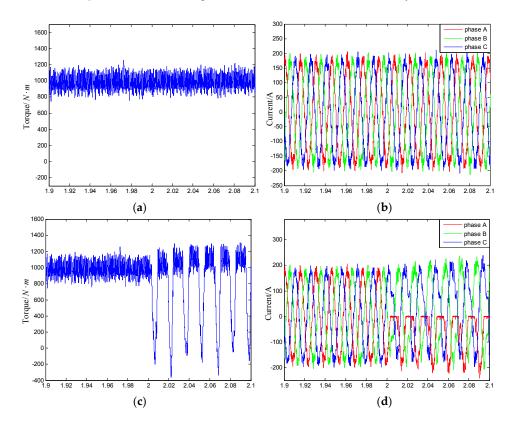


Figure 1. Schematic diagram of the vector controlled traction system.



**Figure 2.** (a) A-phase torque in normal state; (b) A-phase currents in normal state; (c) A-phase torque when *S*1 open switch fault occurs; (d) A-phase currents when *S*1 open switch fault occurs.

With high order vanishing moments wavelets, the detail wavelet decomposition coefficients will become small. When a singularity occurs, the detail coefficients will become large. This characteristic makes it possible for the Discrete Wavelet Transform (DWT) and Discrete Wavelet Packet Transform (DWPT) to detect the open switch faults in traction inverters. In this section, the performances of DWT and DWPT in diagnosing open switch faults in traction inverters are evaluated.

### 2.1. Disadvantages of Wavelet Transform

DWT, which has multi-resolution analysis ability, can decompose the signal into different scales by utilizing the orthogonal wavelet basis as Equation (1) shows:

$$f(t) = \sum_{k} a_m(k)\varphi(t-k) + \sum_{k} \sum_{j} c_j 2^{-j/2} \psi(2^{-j}t-k), \quad j = 1, 2, ..., m$$
(1)

where, f(t) is the original signal,  $\varphi(t)$  is the scaling function,  $\psi(t)$  is the wavelet function,  $a_m$  represents the last scale approximate coefficient and  $c_j$  is the detail coefficients in *j*th scale. By this equation, the time domain signal can be mapped into different scales, or the frequency domain in some way. This process can be expressed as shown in Figure 3. In the first level, the original signal is decomposed into high frequency sub-band  $D_1$  and low frequency sub-band  $A_1$ . In the second level, the low frequency sub-band  $A_1$  is composed into high sub-band  $D_2$  and low frequency sub-band  $A_2$ , as well as in the later levels.

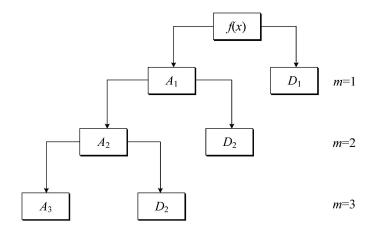


Figure 3. Wavelet decomposition.

To evaluate the performance of the DWT, db2 wavelet is adopted as recommended by [17]. Figure 4 shows the A-phase fault current with *S*1 open and the results of db2 wavelet decomposition with a 50 kHz sampling rate. From the detail coefficients, it is hard to detect the open switch fault. As shown in Figure 5, it is clear that the fault-free current contains the main components at the frequencies of 60, 360, 640, 920 and 1050 Hz. The fundamental frequency is 60 Hz, and the components at other frequencies are called extra components. After the *S*1 open fault occurs, extra components appear around 0 and 130 Hz frequency. The frequency range of each sub-band can be presented as Equation (2):

$$\begin{cases} D_j : [2^{-j} f_{\max}, 2^{-j+1} f_{\max}] \\ A_j : [0, 2^{-j} f_{\max}] \end{cases} \quad j = 1, 2, ..., m$$
(2)

where,  $f_{\text{max}}$  represents the frequency of the highest component. Hence, the frequency range of each sub-band can be obtained as shown in Table 1. Sub-band  $D_1$  contains the extra components of 640 and 920 Hz, sub-band  $D_2$  contains the extra components of 360 Hz, sub-band  $D_3$  contains the extra components around 130 Hz. As each sub-band contains the extra components of the fault current, the

fault signal is covered by the extra components in each sub-band, which makes it difficult to detect the switch open faults.

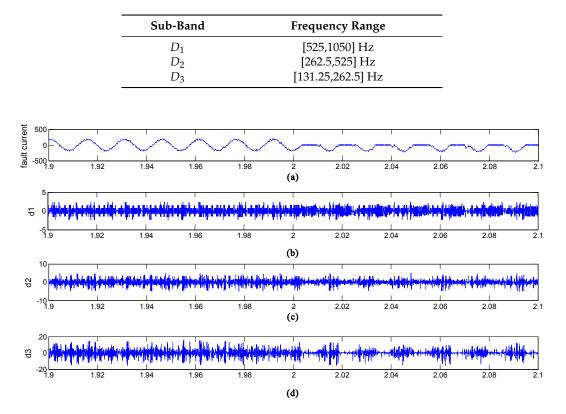
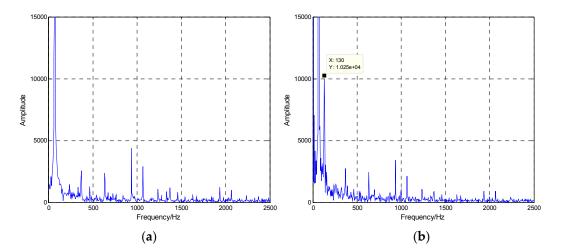


Table 1. Frequency range of each sub-band.

**Figure 4.** (a) A-phase fault current with *S*1 open (50 kHz sampling frequency); (b) First level detail coefficient; (c) Second level detail coefficient; (d) Third level detail coefficient.



**Figure 5.** (a) spectrum of fault free current (50 kHz sampling frequency and 0.2 s acquisition time); (b) spectrum of A-phase fault current with *S*1 open (50 kHz sampling frequency and 0.2 s acquisition time).

#### 2.2. Disadvantages of Discreet Wavelet Packet Transform

As shown in Figure 3, DWT can decompose the approximate part in each level, while the detail part remains unchanged. Consequently, the resolution of DWT is not high enough to separate the fault

signals from the extra components. Differing from DWT, DWPT can decompose the detail part in each level. Hence, its resolution may be high enough to detect the open switch faults. DWPT recursive decomposition can be expressed as follows:

$$\begin{cases} d_{i,2j}(t) = \sqrt{2\sum_{k} g(k)} d_{i-1,j}(2t-k) \\ d_{i,2j-1}(t) = \sqrt{2\sum_{k} h(k)} d_{i-1,j}(2t-k) \\ d_{0,0}(t) = f(x)(t) \end{cases}$$
(3)

where, f(x) represents the original signal, h(k) and g(k) are the high pass filter and low pass filter respectively, and  $d_{i,j}(k)$  is the reconstructed signal of wavelet packet decomposition for the *j*th node at the *i*th level. In this part, db2 wavelet is selected as the mother wavelet as well and Shannon entropy is adopted to search for the best wavelet packet base. In order to eliminate the effects of extra components, the high frequency sub-band that does not contain any extra component should be selected to detect the open switch faults. The frequency of each sub-band after wavelet packet decomposition is depicted in Figure 6, and the 656.25~787.5 Hz sub-band, namely the sixth node in the third level, is selected.

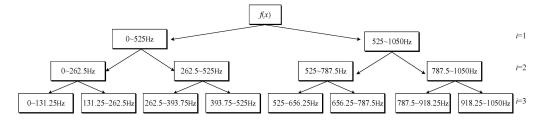


Figure 6. Frequency of each sub-band after wavelet packet decomposition.

Figure 7 shows the DWPT decomposition coefficients of the sixth node in the third level. The fault detection results are much better than that of the DWT, because this sub-band is not affected by the extra components owing to its high resolution in the frequency domain. However, as mentioned in the introduction, the wavelet transform or wavelet packet transform may lead to false alarms in detecting the open switch faults of traction inverters. It can be found in Figure 7 that the false alarms are caused by the sudden change of current amplitude.

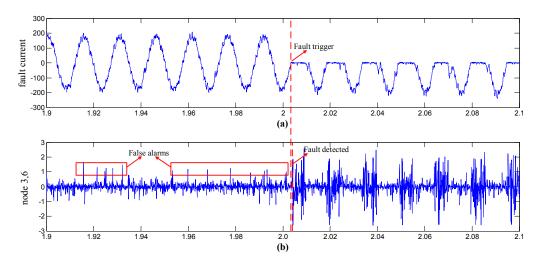


Figure 7. (a) A-phase fault current with S1 open; (b) Coefficients of the sixth node in the third level.

In this section, the performances of DWT and DWPT in diagnosing the open switch faults in traction inverters are discussed. Neither DWT nor DWPT can detect the open switch faults in traction

inverters ideally, though it is possible for DWT and DWPT to detect singularities. The output currents of the traction inverter, namely the stator currents, contain the high frequency extra components both under normal conditions and fault conditions. As the resolution of DWT is not so satisfying in the high frequency domain, the extra components which fall into the high frequency sub-bands cover the fault signals. The decomposition results show that DWT can hardly detect the open switch faults. DWPT has higher resolution than DWT and it can detect the fault. Nevertheless, there is a fatal problem for DWPT to detect the open switch faults. That is to say, the sudden change of the current will lead to the false alarms, hence the detection results are not reliable. Though some measures can be implemented to eliminate the false alarms, they will change the waveform of other phase currents and cause alarms in the fault-free phase, which makes it more difficult to diagnose the simultaneous faults. If this disadvantage of DWPT can be solved, the open switch fault can be detected in a timely way and correctly.

## 3. Proposed Diagnosis Plan

In order to overcome the defects of DWT and DWPT in traction inverter diagnosis, a new plan is proposed. First, the entropy approach is adopted to detect the open switch faults. Five entropy forms, namely, WPESE, WPETE, WPESE<sub>3,6</sub>, EMDESE and EMDETE, are tried and discussed. With the evaluation parameter, the best entropy form that can deal with the false alarms in this case is found. Then, the DC component of the faulty phase current is considered to locate USF and LSF.

## 3.1. Fault Detection Method

## 3.1.1. Wavelet Packet Shannon Entropy and Tsallis Entropy

Entropy can measure the uncertainty of a system. It has been discussed in Section 2 that the fault current has more frequency components than normal current. As a result, the entropy in a fault case is larger than that of a normal case. Hence, Shannon entropy and Tsallis entropy are utilized to detect the faults.

Shannon entropy was firstly proposed by Shannon to solve the measurement problem of information. Supposing a random variable  $X(X = x_1, x_2, ..., x_N, N)$  is the number of probable states) as the state of an uncertain system, the information of one state can be expressed by Equation (4) and the Shannon entropy can be presented as Equation (5):

$$I_j = \log(1/p_j) \tag{4}$$

$$H(X) = -\sum_{j=1}^{N} p_j \log(p_j)$$
(5)

where  $p_i$  is the probability of  $x_i$ , and the sum of  $p_j$  is equal to 1.

By DWPT,  $D_{i,j}(n)$  (n = 1, 2, ..., K) is set as the reconstructed signal of the *i*th node at the *j*th level, n is the index of sampling point. The Wavelet Packet Energy (WPE) of each node at *j*th level can be expressed as Equation (6), and the total energy of the signal  $E_j$  is the sum of WPE of every node. Relative wavelet packet energy  $p_{i,j} = E_{i,j}/E_j$  can be treated as the probability. Hence, the Wavelet Packet Energy Shannon Entropy (WPESE) at *j*th level can be defined as Equation (7):

$$E_{i,j} = \sum_{n=1}^{k} |D_{i,j}(n)|^2$$
(6)

$$WPESE = -\sum_{i=1}^{J} p_{i,j} \log p_{i,j}, \ (J = 2^{j})$$
(7)

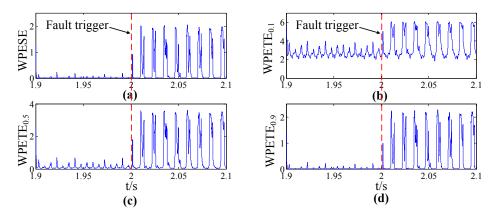
Shannon entropy is a kind of extensive entropy, *i.e.*, it is used for the additive system. Tsallis entropy is one of the non-extensive entropies that can provide the correct physical expression for the non-additive system with a mixed or irregular fragment [21]. The expression of Wavelet Packet Energy Tsallis Entropy (WPETE) is defined as Equation (8):

WPETE = 
$$\frac{1}{q-1} \left( 1 - \sum_{i=1}^{J} (p_{i,j})^q \right)$$
,  $(J = 2^j)$  (8)

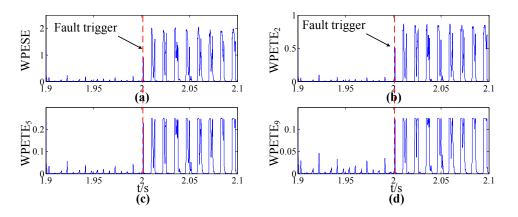
where, *q* represents the non-extensive parameter, the meanings of the rest variables are similar to those in Equation (7).

The non-extensive parameter q plays an important role in Tsallis entropy. When q approaches 0, Tsallis entropy and Shannon entropy are equal, which means the Tsallis entropy is extensive in this occasion. For the wavelet packet decomposition, the coefficients in each scale are generally non-extensive because of the frequency aliasing and energy leakage. Hence, it should be considered carefully. In this paper, q in the range of [0.1,0.9] and [2,9] is considered respectively.

The performances of WPESE and WPETE with different q values for the open switch fault detection problem are shown in Figures 8 and 9. It can be found that the WPESE still has false alarms. However, if the threshold and non-extensive parameter q is set properly, the WPETEs may be able to deal with these false alarms.



**Figure 8.** (a) WPESE of A-phase fault current with *S*1 open; (b) WPETE of A-phase fault current with *S*1 open when q = 0.1; (c) WPETE of A-phase fault current with *S*1 open when q = 0.5; (d) WPETE of A-phase fault current with *S*1 open when q = 0.9.



**Figure 9.** (a) WPESE of A-phase fault current with *S*1 open; (b) WPETE of A-phase fault current with *S*1 open when q = 2; (c) WPETE of A-phase fault current with *S*1 open when q = 5; (d) WPETE of A-phase fault current with *S*1 open when q = 9.

#### 3.1.2. WPESE with a Specific Sub-Band

In Section 3.1.1, the performances of WPESE and WPETE with different non-extensive parameters *q* have been discussed. It can be found that both of them are still under the risk of false alarms, especially WPESE. The WPETE can be better if the non-extensive parameter is selected well because the system is non-extensive as discussed in Section 3.1.1. The reason for the false alarms is that all the sub-bands are used for the entropy calculation, which means all the extra components are considered. Hence, the entropy can be very large under the normal condition. However, if the specific sub-band that does not contain any extra component is selected to calculate the entropy, the false alarms may be eliminated.

It has been proved in Section 2.2 that the sixth node in the third level of db2 wavelet packet decomposition has no extra components if frequency aliasing and energy leakage are ignored. Therefore, this node may be able to deal with the false alarms. Adopting the concept of Shannon entropy, the WPESE of the specific sub-band (WPESE<sub>3,6</sub>) is defined as Equation (9):

$$WPESE_{3,6} = -p_{3,6} \log p_{3,6} \tag{9}$$

Note that, there is only one unit in this system and Tsallis entropy is needless. From the definition of  $WPEE_{3,6}$ , it can be found that, the node's entropy will maintain large value during the occurrence of the fault and approach zero in other conditions. The performance of WPESE<sub>3,6</sub> is shown in Figure 10.

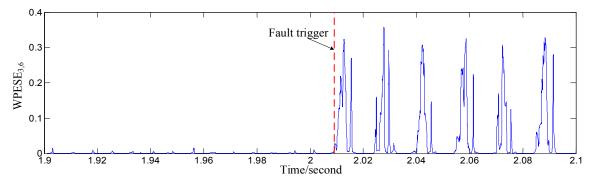


Figure 10. WPETE<sub>3,6</sub> of fault current.

As the energy calculation is based on a period of signal, a sliding window *L* and sliding factor *a* will be needed for the fault detection. The length of the window should not be too long nor too short. A long window will increase the computational cost, as well as the detection time. Short windows may lead to a decrease of detection performance. Similarly, a small sliding factor can reduce the lag between the fault trigger and fault detection. However, the computation will be raised. Hence, both of the parameters should be selected carefully. In Sections 3.1.1 and 3.1.2 L = 50 sampling points and *a* = 1 sampling points are selected. Note that, the L and *a* selection is based on experience which makes the calculation time as short as possible under the premise of not losing the accuracy.

3.1.3. Empirical Mode Decomposition Shannon Entropy and Tsallis Entropy

Good diagnosis performances of EMD are reported in [24,25]. In this section, EMD and EMD entropy are introduced and utilized to detect the open switch fault. Essentially speaking, the EMD method is a kind of smoothing process, which separates the different scale signals to generate several series. Each series is called an IMF, which must satisfy the following constraints [26]:

- (1) In the whole data set, the number of extrema and the number of zero-crossings must either be equal or differ at most by one.
- (2) At any point, the mean value of the envelope defined by local maxima and the envelope defined by the local minima is zero.

The EMD method can be implemented by the following steps:

- (1) Determine all the local extrema of the original signal.
- (2) Connect all the local maxima and minima with cubic spline line, respectively. Thus, the upper envelope and lower envelop can be obtained.
- (3) Denote the average value of upper and lower envelop as  $m_1(t)$ , and denote:

$$h_1(t) = f(x, t) - m_1(t)$$
(10)

- (4) If  $h_1(t)$  satisfies the constraints of IMF, then it is the first IMF of the original signal f(x,t). Else let  $f(x,t) = h_1(t)$ , and repeat the Steps (1)–(3) until  $h_{1(k-1)}(t) m_{1k}(t) = h_{1k}(t)$  (*k* is the iteration number), which means  $h_{1k}(t)$  satisfies the IMF constraints. Denote  $c_1(t) = h_{1k}(t)$ ,  $c_1(t)$  is the first IMF of the original signal.
- (5) Separate  $c_1(t)$  from f(x,t), we can obtain the residual:

$$r_1(t) = f(x,t) - c_1(t)$$
(11)

Let  $r_1(t)$  be the original signal, repeat the Steps (1)–(4), the second IMF  $c_2(t)$  can be obtained.

(6) Repeat the steps above until the residual is monotonous, all the IMFs  $c_1(t)$ ,  $c_2(t)$ , ...,  $c_n(t)$  and the final residual  $r_n(t)$  can be obtained. The original signal can be expressed as:

$$f(x,t) = \sum_{i=1}^{n} c_i(t) + r_n(t)$$
(12)

Each IMF represents a specific frequency which is with respect to the original signal f(x,t). If the f(x,t) changes, for example, affected by the noise, the specific frequency of each IMF will change as well. As a consequence, the EMD energy entropy cannot be analyzed as WPESE, *i.e.*, it is hard to find a specific IMF to avoid the extra components. In this part, EMD energy Shannon entropy (EMDESE) and Tsallis entropy (EMDETE) are discussed, which can be expressed as Equations (13) and (14):

$$EMDESE = -\sum_{i=1}^{n} p_i \log p_i \tag{13}$$

$$EMDETE = \frac{1}{q-1} \left( 1 - \sum_{i=1}^{n} p_i^q \right)$$
(14)

where,  $p_i = c_i / \sum_{j=1}^n c_j$ , *q* is the non-extensive parameter, and *n* is the number of IMFs.

The performances of EMD, EMDESE and EMDETE with non-extensive parameter q in the range of [0.1,0.9] and [2,9] are shown in Figures 11–13 respectively. It can be found from these figures that it is difficult for EMD to detect the fault, while the EMDETE can finish this if the non-extensive parameter is selected properly.

In this section, L = 150 sampling points and a = 1 sampling point.

## 3.1.4. Fault Detection Evaluation

Earlier in this paper, the performances of WPESE, WPETE, WPESE<sub>3,6</sub>, EMDESE and EMDETE in open switch fault detection are discussed with respect to Figures 8–13. In order to evaluate them quantitatively, the evaluation parameter is defined.

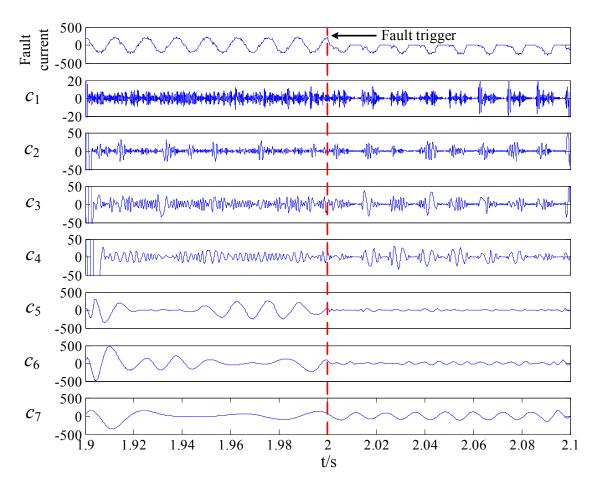
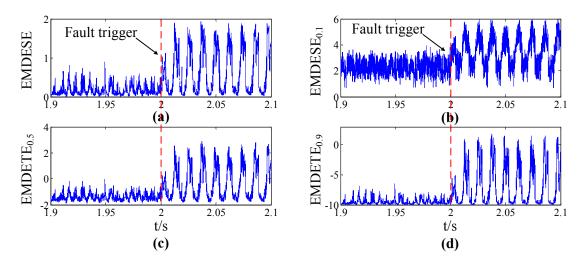
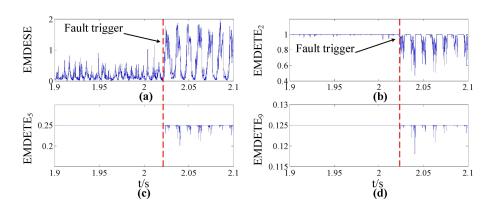


Figure 11. EMD results of A-phase fault current with S1 open.



**Figure 12.** (a) EMDESE of A-phase fault current with *S*1 open; (b) EMDETE of A-phase fault current with *S*1 open when q = 0.1; (c) EMDETE of A-phase fault current with *S*1 open when q = 0.5; (d) EMDETE of A-phase fault current with *S*1 open when q = 0.9.



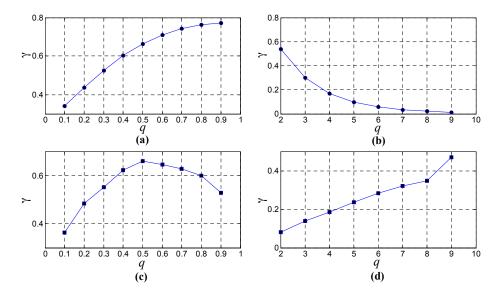
**Figure 13.** (a) EMDESE of A-phase fault current with *S*1 open; (b) EMDETE of A-phase fault current with *S*1 open when q = 2; (c) EMDETE of A-phase fault current with *S*1 open when q = 5; (d) EMDETE of A-phase fault current with *S*1 open when q = 9.

The main obstruction of open switch fault detection is the false alarms caused by the sudden changes of the current. Therefore, the maximum of the entropy in normal condition should be considered and the evaluation parameter  $\gamma$  is defined as follows:

$$\gamma = -\ln\left(\frac{E_n(max) - E_n(min)}{E_f(max) - E_f(min)}\right)$$
(15)

where,  $E_n(max)$  and  $E_n(min)$  represent the maximum and the minimum of the entropy under normal conditions, respectively.  $E_f(max)$  and  $E_f(min)$  indicate the maximum and the minimum of the entropy under fault conditions. From the definition of  $\gamma$ , it can be found that the entropy form with larger  $\gamma$  will be effected less by false alarms.

In order to select the most suitable non-extensive parameters q, evaluation parameter  $\gamma$  of each WPETE and EMDETE with different q are compared, which are shown in Figure 14.



**Figure 14.** (a) WPETE of fault current when q is in the range of [0.1,0.9]; (b) WPETE of fault current when q is in the range of [2,9]; (c) EMDETE of fault current when q is in the range of [0.1,0.9]; (d) EMDETE of fault current when q is in the range of [2,9].

It can be found in Figure 14 that 0.9 is the best non-extensive parameter *q* for WPETE and 0.5 is the best one for EMDETE. In order to select the best entropy form to detect the open switch fault,

the evaluation parameter  $\gamma$  of each entropy form of the fault current is given in Table 2. Obviously, WPESE<sub>3,6</sub> is the best choice in this case as it can deal with the effect of the sudden changes of the current.

Entropy Form	Evaluation Parameter $\gamma$
WPESE	0.21
WPETE <sub>0.9</sub>	0.7724
WPESE <sub>3,6</sub>	3.124
EMDESE	0.498
EMDETE <sub>0.5</sub>	0.66

 Table 2. Evaluation parameter of each entropy form.

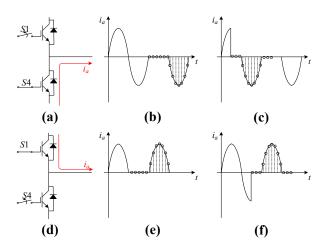
#### 3.2. DC Component and Fault Location

Though WPESE<sub>3,6</sub> has shown its good performance in detecting the fault legs without false alarms, it still has problems in identifying the fault IGBT. As WPESE<sub>3,6</sub> is calculated by the absolute value, it cannot classify the direction. Hence in this part, the DC component  $I_{dc}$  is introduced to overcome this defect, which is depicted as Equation (16):

$$I_{dc} = \frac{1}{M} \sum_{m=1}^{M} I_i(m)$$
 (16)

where, *M* is the number of sampling points in one cycle, *i* represents the phase index.

Figure 15 shows A-phase current flows and current waves of USF and LSF. When the USF occurs, the current cannot go through *S*1, *i.e.*, the positive current must be zero. However, the negative current can go through the anti-parallel diode of *S*4. The current wave can be seen in Figure 15b,c. If the USF occurs in the negative current flow, the current wave will remain normal until the current crosses zero. Moreover, the positive current will be replaced by zero in the next periods. If it occurs in the positive current will approach zero immediately. Apparently, sampling points' values of the current wave is shown in the Figure 15e,f, sampling points' values of the current are almost positive after fault triggering. The analysis of LSF is similar to that of USF and the current wave is shown in the Figure 15e,f, sampling points' values of the current are almost positive after fault triggering. From the discussion, it is clear that the DC component of the fault current will be negative after the USF, and positive after the LSF. Thus, when the fault is detected, the average value of samples during the next cycle, *i.e.*, the DC component, can be calculated to identify the fault IGBT or IGBTs.



**Figure 15.** (**a**) Current flow of USF; Current wave when USF occurs in(**b**) negative current flow; (**c**) positive current flow; (**d**) Current flow of LSF; Current wave when LSF occurs in (**e**) positive current flow; (**f**) negative current flow.

The open switch fault diagnosis plan can be implemented by the following steps, which is shown in the flowchart in Figure 16:

- (1) Utilize the FFT to determine the extra components of the normal current and fault current. By analyzing the frequency of each sub-band of DWPT, the sub-band that do not contain the extra component is selected. In this case, the sixth node in the third level is selected.
- (2) The parameters such as the length of the sliding window *L* and the sliding factor *a* should be set.
- (3) The WPESE<sub>3,6</sub> of each phase current in the sliding window should be calculated. If the WPESE<sub>3,6</sub> exceeds the predefined threshold TWPEE, the corresponding leg is faulty.
- (4) If a leg is detected as faulty, DC component  $I_{dc}$  of the corresponding phase current in the next cycle shold be calculated. If  $I_{dc}$  is larger than  $+T_{DC}$ , the LSF is isolated. If  $I_{dc}$  is less than  $-T_{DC}$ , the LSF is isolated. Otherwise, simultaneous USF and LSF are isolated.

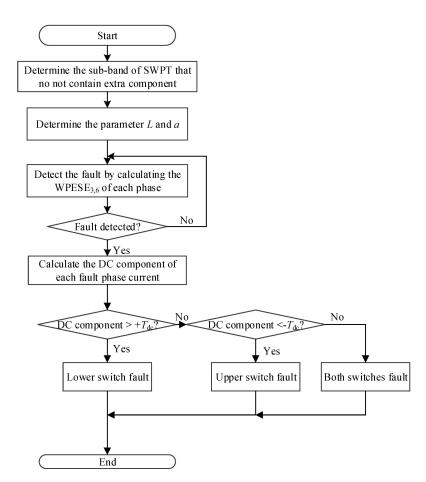


Figure 16. Flow chart of the proposed method.

## 4. Simulation and Discussion

To validate the effectiveness of the idea proposed in this paper, simulation evaluation is carried out. A closed loop controlled traction system simulation model is established in SIMULINK. This system mainly comprises a traction motor (a squirrel cage induction motor), a traction inverter and a control part, as shown in Figure 1. The control part takes the responsibility for performing vector control and diagnosis. Space vector pulse width modulation is adopted to drive the traction inverter. The open switch fault is carried out by removing the drive signal of the corresponding IGBT and the anti-paralleled diode can still work. Forward voltage of each IGBT and paralelled diode is 1.4 V, fall time and tail of time each IGBT are 1  $\mu$ s and 2  $\mu$ s, respectively. The parameters of the traction motor are shown in Table 3.

Parameter	Value
Stator resistance/ $R_s$	0.15 Ω
Stator inductance/ $L_s$	0.00142 H
Rotator resistance/ $R_r$	0.16 Ω
Rotator inductance $/L_r$	0.006 H
Mutual inductance/ $L_{\rm m}$	0.0254 H
Inertia/J	$10 \text{ kg} \cdot \text{m}^2$
Nominal line voltage	2700 V
Nominal frequency	138 Hz
Pole pairs	2
Nominal power	562 kVA

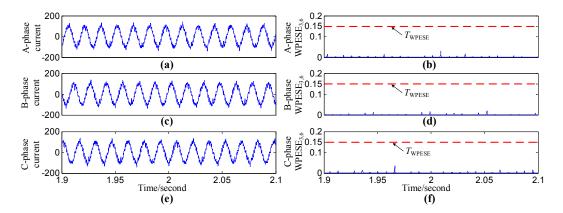
Table 3. Parameters of the traction motor.

The voltage of the DC bus is 3000 V and the switch frequency is 12.5 kHz. In this section, two kinds of traction inverter open switch faults are considered:

- Fault A: Just one open switch fault occurs at leg A on the upper IGBT(S1).
- Fault B: Two simultaneous open switch faults occur at leg A on the upper IGBT(*S*1) and at leg B on the lower IGBT(S6).

#### 4.1. Fault-Free Case

In order to prove that the proposed method will not cause false alarms, the fault free condition is simulated. Because the WPESE<sub>3,6</sub> is not zero in the normal condition, the threshold  $T_{WPESE}$  must be set to distinguish between the normal condition and fault condition. If WPESE<sub>3,6</sub> exceeds the  $T_{WPESE}$ , it can be judged that the corresponding leg is faulty. According to experience, the threshold  $T_{WPESE}$  is set to 0.15,  $+T_{DC}$  and  $-T_{DC}$  are set to 20 and -20 respectively, the length of sliding window is set to 50 sampling points and the sliding factor is selected as 1. Figure 17 depicts the current and WPESE<sub>3,6</sub> in normal condition. It is clear that all the WPESE<sub>3,6</sub> has not exceeded the threshold, showing the proposed method will not cause false alarm in normal condition.



**Figure 17.** (a) A-phase current in normal condition; (b) A-phase WPESE<sub>3,6</sub>; (c) B-phase current in normal condition; (d) B-phase WPESE<sub>3,6</sub>; (e) C-phase current in normal condition; (f) C-phase WPESE<sub>3,6</sub>.

## 4.2. Fault A Case

To validate the effectiveness of the proposed plan in single fault condition, the *S*1 fault (fault A) is set at 1.725 s. The reference speed change is set as well to show that the proposed plan is robust to speed changes and torque changes.

As depicted in Figure 18, the reference speed is changed from 208 rad/s to 500 rad/s at 1.5 s and the torque is changed correspondingly. The open switch fault occurs on S1 at 1.725 s. Figure 19 shows the WPESE<sub>3,6</sub> of each phase and the DC component of A phase. It can be seen that when the speed and torque change, the phase current becomes larger. However, the WPESE<sub>3,6</sub> of each phase maintains unchanged, which means the WPESE<sub>3,6</sub> is insensitive to the speed change and torque change. When the fault occurs, the WPESE<sub>3,6</sub> of A phase exceeds the T<sub>WPEE</sub> while B phase's and C phase's do not, indicating that only A phase leg is faulty. After the A leg is detected as faulty, the DC component of A phase should be calculated. As Figure 19c shows, the A-phase DC component has exceeded the  $-T_{DC}$ , the S1 open switch fault is diagnosed, and the diagnosis time is about one cycle.

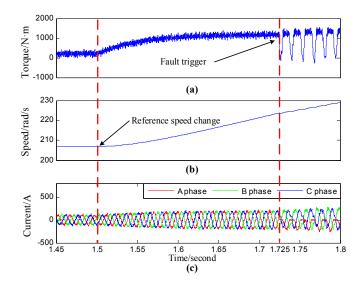
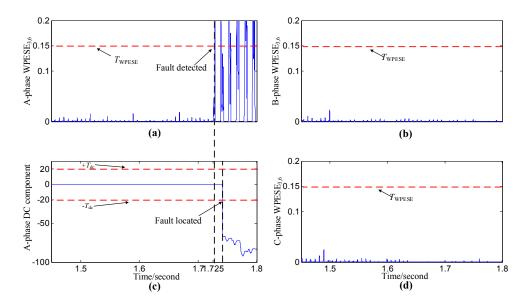


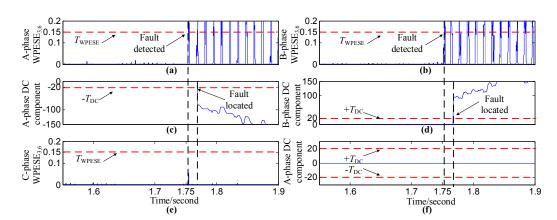
Figure 18. Normal condition (a) Torque; (b) Speed of the traction motor; (c) Three phase current.



**Figure 19.** Fault A condition (**a**) A-phase WPESE<sub>3,6</sub>; (**b**) B-phase WPESE<sub>3,6</sub>; (**c**) A-phase DC component; (**d**) C-phase WPESE<sub>3,6</sub>.

## 4.3. Fault B Case

To validate the performance of the proposed diagnosis plan under simultaneous faults condition, S1 fault and S6 fault (fault B) are set at 1.75 s, and the reference speed change is set as well in this condition. Figure 20 depicts WPESE<sub>3,6</sub> and DC component of each phase. A-phase WPESE<sub>3,6</sub> and



B-phase WPESE<sub>3,6</sub> has exceeded the threshold at 1.755 s, indicating that there are faults at leg A and leg B.

**Figure 20.** Fault B condition (**a**) A-phase WPESE<sub>3,6</sub>; (**b**) B-phase WPESE<sub>3,6</sub>; (**c**) A-phase DC component; (**d**) B-phase DC component; (**d**) C-phase WPESE<sub>3,6</sub>; (**f**) C-phase DC component.

Though there is a smallish C phase WPESE<sub>3,6</sub> pulse at 1.755 s, it does not exceed the threshold, so no false alarm is caused. By calculating the DC component of each fault phase, USF of A leg and LSF of B leg are identified, *i.e.*, S1 and S6 open switch faults are diagnosed, and the diagnosis time is about one cycle. Simulation validation of the proposed plan is implemented in this section. The results show that the proposed plan is robust to speed and torque changes, *i.e.*, when the speed and torque of the traction motor change, no false alarms will be caused. In addition, the WPESE<sub>3,6</sub> of each phase is independent of other phases, which makes faulty leg detection possible. The DC component can isolate the failure IGBT. Both single fault and simultaneous faults can be diagnosed in about one cycle.

## 5. Conclusions

Aiming at the problem of open switch faults of traction inverters in high-speed railways, a diagnosis plan is proposed in this paper. This plan contains two steps, namely, the fault detection part with entropy approach and fault location part with DC component approach. In the fault detection part, traditional fault detection methods, namely, DWT and DWPT, are discussed at first. Both of them cannot efficiently detect the open switch faults of traction inverters because of low resolution or the sudden change of the current. Then, the performances of five entropy forms, including WPESE, WPETE, WPESE<sub>3,6</sub> EMDESE, EMDETE, were discussed for the open switch fault detection, and the evaluation parameter  $\gamma$  is defined to evaluate them. The comparison results show that the system is non-extensive and non-extensive parameter q = 0.9 for WPETE and q = 0.5 for EMDETE are most suitable, respectively. Tsallis entropies of DWPT and EMD have better detection performance than their Shannon entropies for the open switch fault detection. However, WPESE<sub>3,6</sub> gets rid of the extra components by selecting the sixth node of the third level of DWPT, and the effects of the currents' sudden change is eliminated. Hence the WPESE<sub>3,6</sub> has the best performance.

In the fault location part, DC component is adopted to settle the problem that entropy is not directional as it is calculated by absolute value. DC component will exceed the positive threshold for LSF and exceed the negative threshold for USF. In addition, the single fault and simultaneous faults simulation experiments are implemented, and the results show that the proposed diagnosis plan can identify the failure IGBT in about one cycle correctly.

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Conflicts of Interest: The authors declare no conflict of interest.

## Nomenclature

DWPT	Discrete Wavelet Packet Transform
DWT	Discrete Wavelet Transform
EMD	Empirical Mode Decomposition
EMDESE	Empirical Mode Decomposition Shannon Entropy
EMDETE	Empirical Mode Decomposition Tsallis Entropy
IGBT	Isolated Gate Bipolar Transistor
LSF	Lower Switch Fault
SPD	Semiconductor Power Devices
TDC	Threshold for the DC component
TWESE	Threshold for the WPESE3,6
USF	Upper Switch Fault
WPETE	Wavelet Packet Energy Tsallis Entropy
WPESE	Wavelet Packet Energy Shannon Entropy
$\gamma$	Evaluation parameter for different entropies

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